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FDFS2P106A

Integrated 60V P-Channel PowerTrench® MOSFET and Schottky Diode

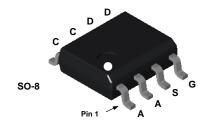
General Description

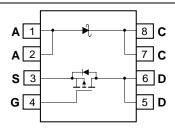
The FDFS2P106A combines the exceptional performance of Fairchild's PowerTrench MOSFET technology with a very low forward voltage drop Schottky barrier rectifier in an SO-8 package.

This device is designed specifically as a single package solution for DC to DC converters. It features a fast switching, low gate charge MOSFET with very low onstate resistance. The independently connected Schottky diode allows its use in a variety of DC/DC converter topologies.

Features

- -3.0 A, -60V $R_{DS(ON)} = 110 \text{ m}\Omega$ @ $V_{GS} = -10 \text{ V}$ $R_{DS(ON)} = 140 \text{ m}\Omega$ @ $V_{GS} = -4.5 \text{ V}$
- V_F < 0.45 V @ 1 A (T_J = 125°C)
 V_F < 0.53 V @ 1 A
 V_F < 0.62 V @ 2 A
- Schottky and MOSFET incorporated into single power surface mount SO-8 package
- Electrically independent Schottky and MOSFET pinout for design flexibility





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	MOSFET Drain-Source Voltage		-60	V
V _{GSS}	MOSFET Gate-Source Voltage		±20	V
I _D	Drain Current - Continuous	(Note 1a)	-3	А
	- Pulsed		-10	
P _D	Power Dissipation for Dual Operation		2	W
	Power Dissipation for Single Operation	(Note 1a)	1.6	
		(Note 1b)	1	
		(Note 1c)	0.9	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C
V_{RRM}	Schottky Repetitive Peak Reverse Voltage)	45	V
Io	Schottky Average Forward Current	(Note 1a)	1	А

Package Marking and Ordering Information

Device Marking Device		Reel Size	Tape width	Quantity	
FDFS2P106A FDFS2P106A		13"	12mm	2500 units	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			l		
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$	-60			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		-60		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -48 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μΑ
I _{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 20V$, $V_{DS} = 0 V$			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V}$ $V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1	-1.6	-3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to $25^{\circ}C$		4		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = -10 \text{ V}, I_D = -3 \text{A}$ $V_{GS} = -4.5 \text{ V}, I_D = -2.7 \text{ A}$ $V_{GS} = -10 \text{ V}, I_D = -3 \text{ A}, T_J = 125^{\circ}\text{C}$		91 112 150	110 140 192	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = -10 \text{ V}, V_{DS} = -5 \text{ V}$	-10			Α
g _{FS}	Forward Transconductance	$V_{DS} = -5 \text{ V}, \qquad I_{D} = -3.3 \text{ A}$		8		S
Dynamic	Characteristics		•	•		•
C _{iss}	Input Capacitance	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V},$		714		pF
Coss	Output Capacitance	f = 1.0 MHz		84		pF
C _{rss}	Reverse Transfer Capacitance			33		pF
Switchir	ng Characteristics (Note 2)	1	ı	1	ı	1
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -30 \text{ V}, I_{D} = -1 \text{ A},$		8	15	ns
t _r	Turn-On Rise Time	$V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$		11	19	ns
t _{d(off)}	Turn-Off Delay Time			28	45	ns
t _f	Turn-Off Fall Time			8.5	17	ns
Q_g	Total Gate Charge	$V_{DS} = -30V$, $I_{D} = -3A$,		15	21	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V		2		nC
Q_{gd}	Gate-Drain Charge	1		3		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings	•		•	
Is	Maximum Continuous Drain–Source				-1.3	Α
V_{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -1.3 \text{ A} \text{(Note 2)}$		-0.8	-1.2	V

Electrical Characteristics (continued) T_A = 25°C unless otherwise noted

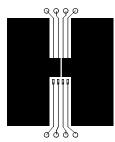
Symbol	Parameter	Test Cor	nditions	Min	Тур	Max	Units
Schottky Diode Characteristics							
I _R	Reverse Leakage	V _R = 45 V	T _J = 25°C		2.8	80	μΑ
			T _J = 125°C		2.2	80	mA
V _F	Forward Voltage	I _F = 1 A	T _J = 25°C		0.44	0.53	V
			T _J = 125°C		0.34	0.45	
		I _F = 2 A	T _J = 25°C		0.49	0.62	
			T _J = 125°C		0.42	0.57	

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

Notes:

R_{0,JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of
the drain pins. R_{0,C} is guaranteed by design while R_{0,CA} is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in² pad of 2 oz copper



125°C/W when mounted on a 0.02 in² pad of 2 oz copper



135°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < $300\mu s$, Duty Cycle < 2.0%

Typical Characteristics

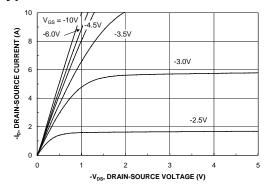


Figure 1. On-Region Characteristics.

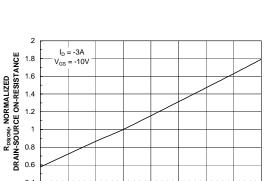


Figure 3. On-Resistance Variation with Temperature.

T_J, JUNCTION TEMPERATURE (°C)

125

150

-50

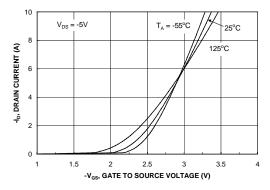


Figure 5. Transfer Characteristics.

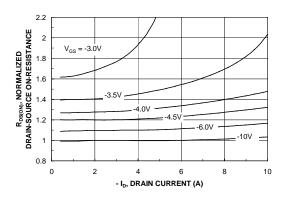


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

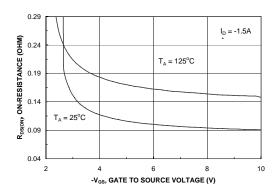


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

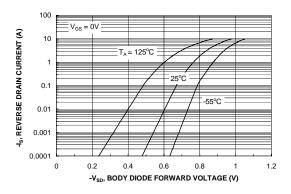
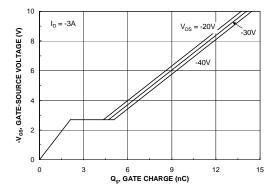


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



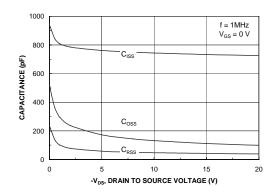
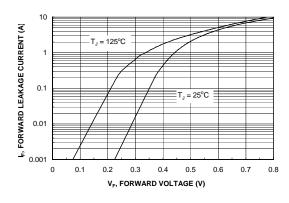


Figure 7. Gate Charge Characteristics.





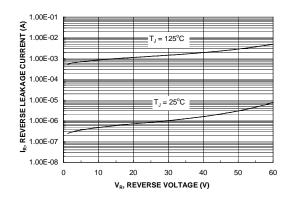


Figure 9. Schottky Diode Forward Voltage.

Figure 10. Schottky Diode Reverse Current.

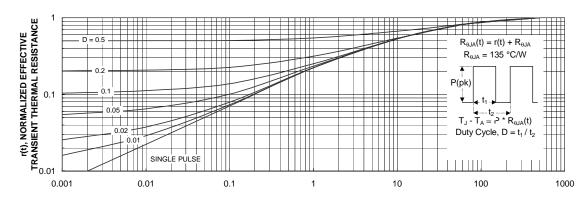


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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